

PROCEEDINGS OF SPIE

Optical Pattern Recognition XIX

David P. Casasent
Tien-Hsin Chao
Editors

17–18 March 2008
Orlando, Florida, USA

Sponsored and Published by
SPIE

Volume 6977

Proceedings of SPIE, 0277-786X, v. 6977

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Author(s), "Title of Paper," in *Optical Pattern Recognition XIX*, edited by David P. Casasent, Tien-Hsin Chao, Proceedings of SPIE Vol. 6977 (SPIE, Bellingham, WA, 2008) Article CID Number.

ISSN 0277-786X
ISBN 9780819471680

Published by

SPIE

P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445
SPIE.org

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